Annex A: System Check

Tested Model: LJ8

Report Number:

WSCT-ANAB-R&E250500034A-SAR

Measurement Report for Device, , , UID 0 -, Channel 0 (750.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	750.000,	9.16	0.885	43.9
Head Simulating			0	0			
Liquid							

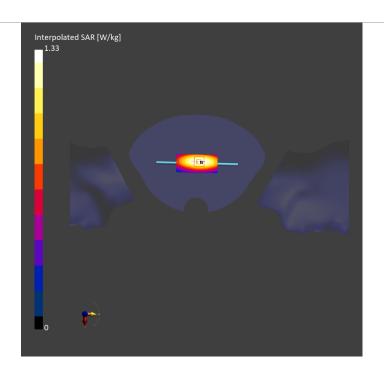
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 90.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-03-11	2025-03-11
psSAR1g [W/kg]	0.853	0.858
psSAR10g [W/kg]	0.573	0.570
Power Drift [dB]	0.00	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		86.4
Dist 3dB Peak [mm]		22.1



Measurement Report for Device, , , UID 0 -, Channel 0 (835.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	835.000,	8.89	0.914	416
Head Simulating			0	0			
Liquid							

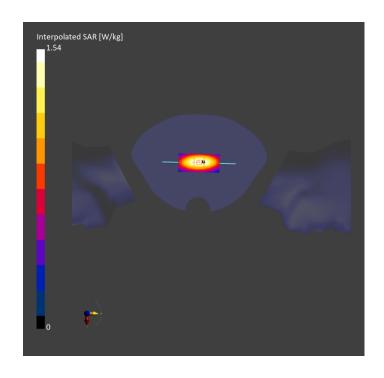
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 90.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-03-14	2025-03-14
psSAR1g [W/kg]	0.993	0.994
psSAR10g [W/kg]	0.653	0.655
Power Drift [dB]	0.01	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		86.2
Dist 3dB Peak [mm]		16.4



Measurement Report for Device, , , UID 0 -, Channel 0 (1750.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	1750.000,	7.6	1.34	41.9
Head Simulating			0	0			
Liquid							

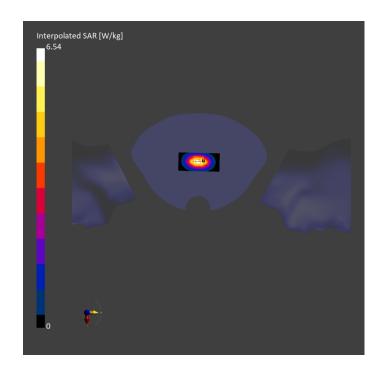
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 90.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-03-18	2025-03-18
psSAR1g [W/kg]	3.62	3.62
psSAR10g [W/kg]	1.92	1.95
Power Drift [dB]	0.01	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		83.2
Dist 3dB Peak [mm]		10.8



Measurement Report for Device, , , UID 0 -, Channel 0 (1900.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	1900.000,	7.33	1.44	41.7
Head Simulating			0	0			
Liquid							

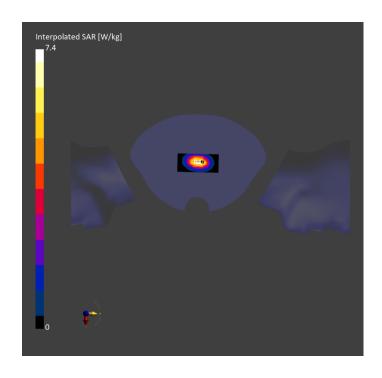
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 90.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-03-21	2025-03-21
psSAR1g [W/kg]	4.01	4.04
psSAR10g [W/kg]	2.10	2.11
Power Drift [dB]	-0.01	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		83.0
Dist 3dB Peak [mm]		9.6



Measurement Report for Device, , , UID 0 -, Channel 0 (2550.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	2550.000,	6.94	1.90	40.8
Head Simulating			0	0			
Liquid							

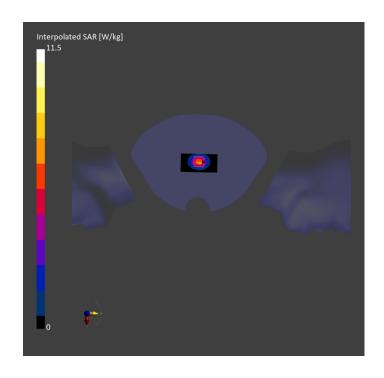
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

Area Scan	Zoom Scan
40.0 x 80.0	30.0 x 30.0 x 30.0
10.0 x 10.0	5.0 x 5.0 x 1.5
3.0	1.4
N/A	Yes
N/A	1.5
N/A	N/A
VMS + 6p	VMS + 6p
Measured	Measured
	40.0 x 80.0 10.0 x 10.0 3.0 N/A N/A N/A VMS + 6p

		Area Scan	Zoom Scan
Date		2025-03-27	2025-03-27
psSAR1g [\	V/kg]	5.48	5.58
psSAR10g	[W/kg]	2.53	2.56
Power Drif	t [dB]	0.00	0.01
Power Scal	ing	Disabled	Disabled
Scaling Fac	tor [dB]		
TSL Correct	tion	No correction	No correction
M2/M1 [%]		80.5
Dist 3dB P	eak [mm]		9.0



Measurement Report for Device, , , UID 0 -, Channel 0 (3400.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	3400.000,	6.14	2.63	39.3
Head Simulating			0	0			
Liquid							

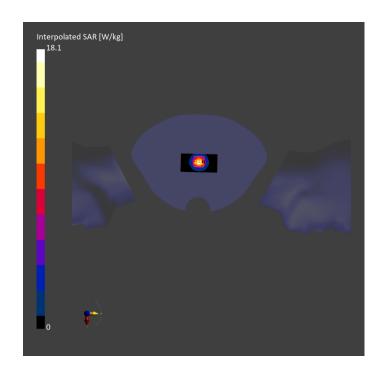
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-03	2025-04-03
psSAR1g [W/kg]	7.11	7.25
psSAR10g [W/kg]	2.77	2.81
Power Drift [dB]	-0.07	0.25
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		76.2
Dist 3dB Peak [mm]		8.1



Measurement Report for Device, , , UID 0 -, Channel 0 (3500.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type	
Device,	50.0 x 10.0 x 8.0		Dipole	

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	3500.000,	6.22	2.94	39.2
Head Simulating			0	0			
Liquid							

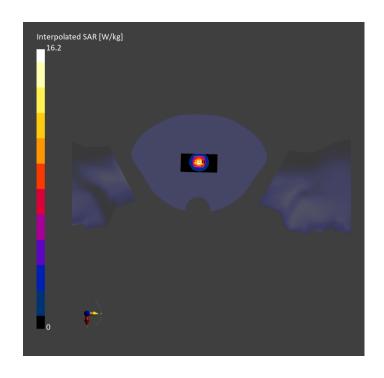
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-09	2025-04-09
psSAR1g [W/kg]	6.11	6.28
psSAR10g [W/kg]	2.36	2.40
Power Drift [dB]	0.01	0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		75.3
Dist 3dB Peak [mm]		8.1



Measurement Report for Device, , , UID 0 -, Channel 0 (3700.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	3700.000,	6.24	2.90	38.9
Head Simulating			0	0			
Liquid							

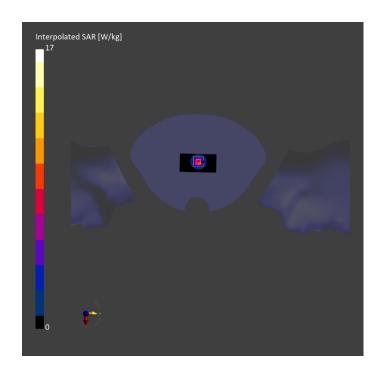
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-12	2025-04-12
psSAR1g [W/kg]	6.09	6.37
psSAR10g [W/kg]	2.31	2.37
Power Drift [dB]	0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.1
Dist 3dB Peak [mm]		8.0



Measurement Report for Device, , , UID 0 -, Channel 0 (3900.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	3900.000,	6.11	3.10	38.6
Head Simulating			0	0			
Liquid							

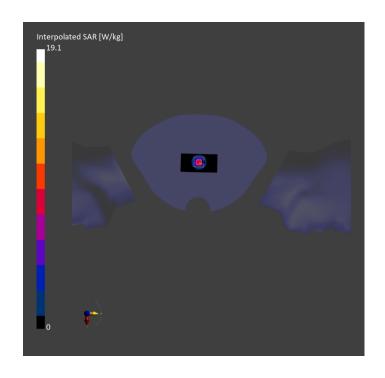
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-17	2025-04-17
psSAR1g [W/kg]	6.61	6.74
psSAR10g [W/kg]	2.34	2.38
Power Drift [dB]	-0.05	-0.06
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		72.9
Dist 3dB Peak [mm]		8.0



Measurement Report for Device, , , UID 0 -, Channel 0 (5200.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	5200.000,	5.34	4.54	36.3
Head Simulating			0	0			
Liquid							

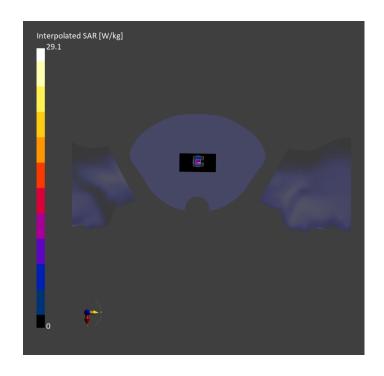
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-21	2025-04-21
psSAR1g [W/kg]	6.41	7.17
psSAR10g [W/kg]	1.91	2.07
Power Drift [dB]	0.02	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		62.3
Dist 3dB Peak [mm]		7.2



Measurement Report for Device, , , UID 0 -, Channel 0 (5300.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	5300.000,	5.28	4.65	36.2
Head Simulating			0	0			
Liquid							

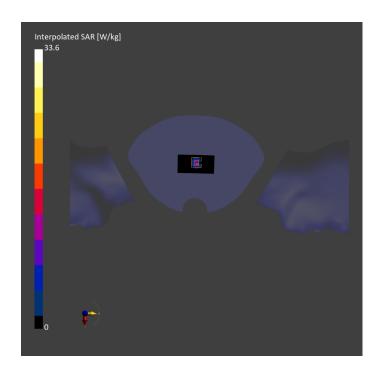
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-23	2025-04-23
psSAR1g [W/kg]	7.15	8.08
psSAR10g [W/kg]	2.09	2.31
Power Drift [dB]	0.01	0.08
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		61.4
Dist 3dB Peak [mm]		7.2



Measurement Report for Device, , , UID 0 -, Channel 0 (5500.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	5500.000,	4.87	4.88	35.8
Head Simulating			0	0			
Liquid							

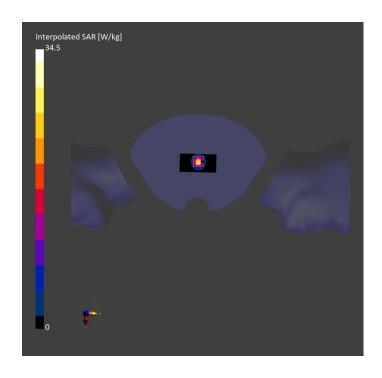
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

ea Scan	Zoom Scan
0 x 80.0 22.0 x	22.0 x 22.0
0 x 10.0 4.0	$0 \times 4.0 \times 1.4$
3.0	1.4
N/A	Yes
N/A	1.4
N/A	N/A
ЛS + 6 р	VMS + 6p
easured	Measured
	0 x 80.0 22.0 x 0 x 10.0 4.0 3.0 N/A N/A N/A N/A N/S + 6p

	Area Scan	Zoom Scan
Date	2025-04-25	2025-04-25
psSAR1g [W/kg]	6.98	7.90
psSAR10g [W/kg]	2.03	2.25
Power Drift [dB]	0.03	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		59.5
Dist 3dB Peak [mm]		7.2



Measurement Report for Device, , , UID 0 -, Channel 0 (5600.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	5600.000,	4.87	5.00	35.6
Head Simulating			0	0			
Liquid							

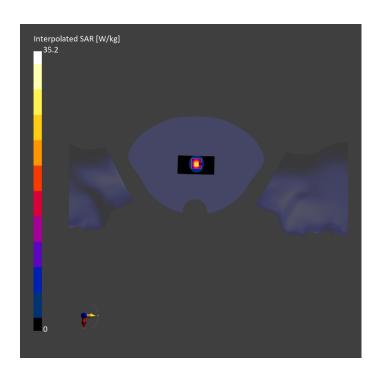
Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-25	2025-04-25
psSAR1g [W/kg]	7.00	7.87
psSAR10g [W/kg]	2.04	2.24
Power Drift [dB]	0.02	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		58.4
Dist 3dB Peak [mm]		7.2



Measurement Report for Device, , , UID 0 -, Channel 0 (5800.000MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 8.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat,	,		CW,	5800.000,	4.84	5.23	35.3
Head Simulating			0	0			
Liquid							

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V5.0 (30deg probe tilt) -	HBBL-600-10000 Charge:xxxx,	EX3DV4 - SN7895, 2024-10-28	DAE4ip Sn1872, 2024-10-18
2243			

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

	Area Scan	Zoom Scan
Date	2025-04-28	2025-04-28
psSAR1g [W/kg]	6.76	7.76
psSAR10g [W/kg]	2.00	2.20
Power Drift [dB]	0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		56.9
Dist 3dB Peak [mm]		7.6

